

深圳市金航标电子有限公司

客户名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	KH-3216F245C04
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type 04
版本 VERSION	:	V2.0
日期 ISSUE DATE	:	2018/07/01



	エ 程 部 R&D CENTER	
承 認 APPROVAL	確認 CHECKED	製 作 DRAWN
Ray	Nate	Kelvin



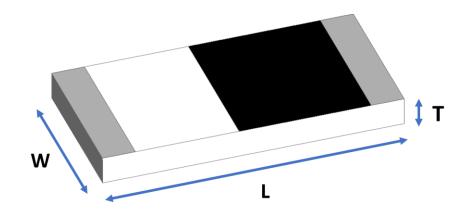
深圳市金航标电子有限公司

深圳市龙华区民治大道1079号展滔科技大厦C座809



# 3216 Chip antenna

## For Bluetooth / WLAN Applications



#### P/N: KH3216F245C04

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	0.45 ± 0.20



## **Part Number Information**

<u> </u>	<u>3216</u>	<u>F</u>	<u>245</u>	<u>C</u>	<u>04</u>
Α	В	С	D	Ε	F
<b></b>					

Α	Product Series	Antenna
B	Dimension L x W	3.2X1.6mm (+-0.2mm)
С	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
Ε	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type=04

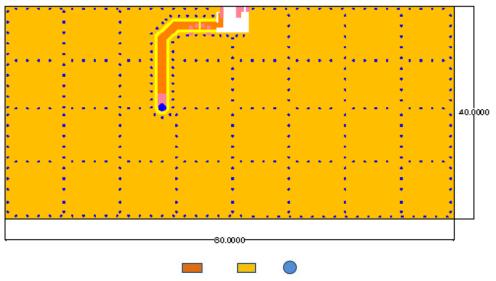
## **1. Electrical Specification**

Specification										
Part Number	KH3216F245C04									
Central Frequency	2450	MHz								
Bandwidth	120 (Min.)	MHz								
Return Loss	-6.5 (Max)	dB								
Peak Gain	1.75	dBi								
Impedance	50	Ohm								
Operating Temperature	-40~+85	°C								
Maximum Power	4	W								
Resistance to Soldering Heats	10 ( @ 260°C )	sec.								
Polarization	Linear									
Azimuth Beamwidth	Omni-directional									
Termination	Ni / Au (Leadless)									

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page



2. Recommended PCB Pattern Evaluation Board Dimension



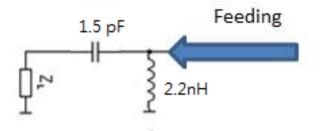
Feed Line TOP Copper VIA

## 2<sup>nd</sup> Evaluation Board Dimension

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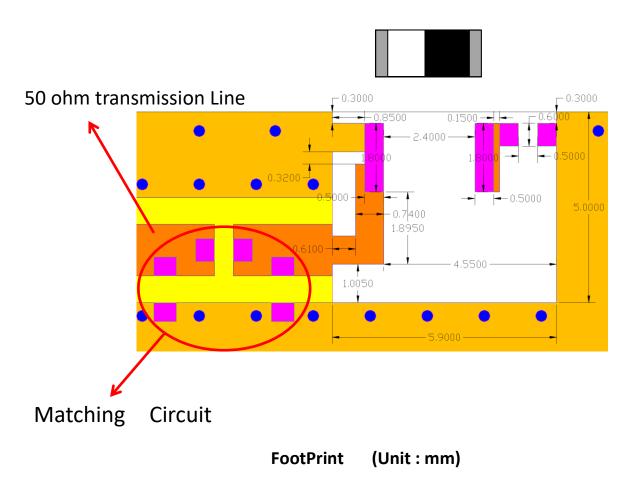
## **Suggested Matching Circuit**

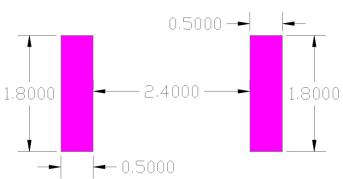
<u>重要資訊</u>: 匹配元件建議使用精準度±1%以下的電感、電容、電阻



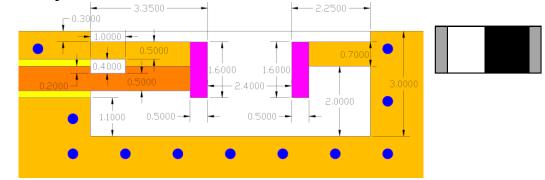


Layout Dimensions in Clearance area(Size=5.9\*5.0mm)





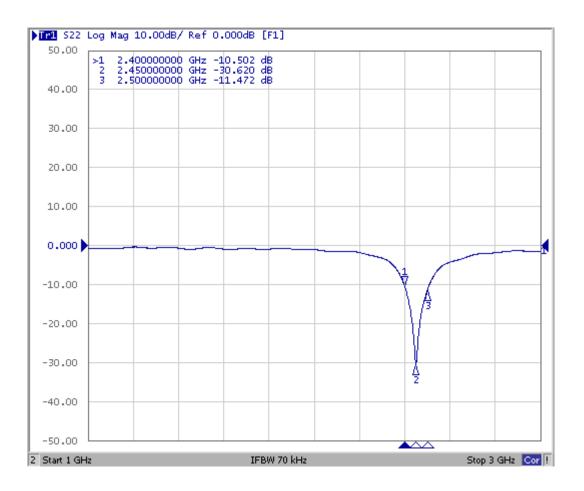
◆ 2<sup>nd</sup> Layout Dimensions in Clearance area(size=8.0\*3.0mm)



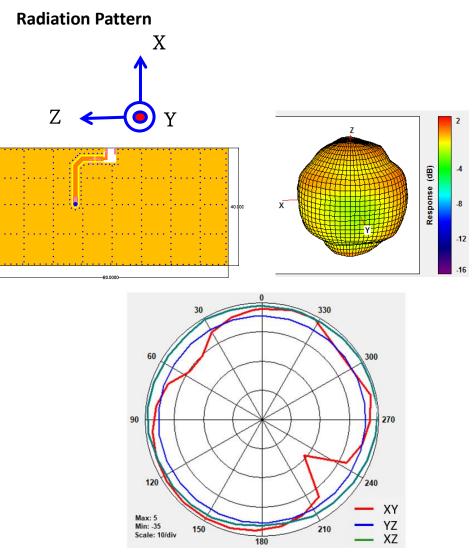


## 3. Measurement Results

#### **Return Loss**

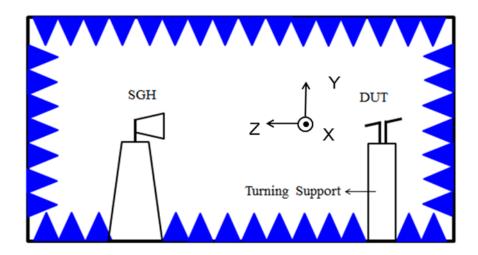






	Efficiency	Peak Gain	Directivity
2450MHz	85.65%	2.21 dBi	2.89 dBi

Chamber Coordinate System





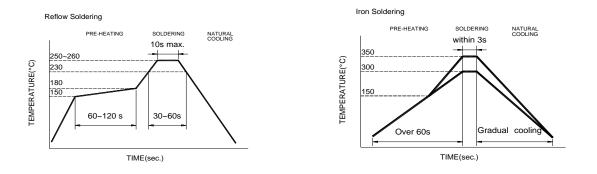
## 4.Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION					
Solderability	1. Wetting shall exceed 90% coverage	Pre-heating temperature:150°C /60sec.					
	2. No visible mechanical damage	Solder temperature:230 $\pm$ 5 $^{\circ}$ C					
	TEMP (°C)	Duration:4±1sec.					
		Solder:Sn-Ag3.0-Cu0.5					
	230°C 4±1 sec.	Flux for lead free: rosin					
	150°C						
	60sec						
Solder heat Resistance	<ol> <li>No visible mechanical damage</li> <li>Central Freq. change :within ± 6%</li> </ol>	Pre-heating temperature:150°C /60sec.					
Resistance		Solder temperature:260±5°C					
	TEMP (°C)	Duration:10±0.5sec.					
	260°C 10±0.5 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin					
		Flux for lead free. Tosifi					
	150°C						
Component	1. No visible mechanical damage	The device should be reflow					
Adhesion (Push test)		soldered(230 $\pm$ 5 $^{\circ}$ C for 10sec.) to a tinned					
(Fush lest)		copper substrate A dynometer force					
		gauge should be applied the side of the					
		component. The device must with-ST-F 0.5 Kg without failure of the termination					
		attached to component.					
Component	1. No visible mechanical damage	Insert 10cm wire into the remaining open					
Adhesion		eye bend ,the ends of even wire lengths					
(Pull test)		upward and wind together.					
		Terminal shall not be remarkably					
		damaged.					
Thermal shock	1. No visible mechanical damage	+85°C =>30±3min					
	<u> </u>	-40°C=>30±3min					
	2. Central Freq. change :within ±6%	Test cycle:10 cycles					
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal					
	1 +85±5℃ 30±3	condition for 2~3 hours before					
	2 Room Within	measuring.					
	Temperature 3sec						
	3 -40±2°C 30±3						
	4 Room Within						
	Temperature 3sec						
Resistance to	1. No visible mechanical damage	Temperature: 85±5°C					
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs					
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal					
	5. No disconnection of short circuit.	condition for 2~3 hours before measuring.					
Resistance to	1. No visible mechanical damage	Temperature:-40±5°C					
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs					
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal					
		condition for 2~3 hours before measuring.					
Humidity	1. No visible mechanical damage	Temperature: 40±2°C					
· ···,		Humidity: 90% to 95% RH					
	2. Central Freq. change :within ±6%	Duration: 1000±12hrs					
	3. No disconnection or short circuit.	The chip shall be stabilized at normal					
		condition for 2~3 hours before					
		measuring.					
	1	measunny.					



#### **5.Soldering and Mounting**

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



Recommended temperature profiles for re-flow soldering in Figure 1.

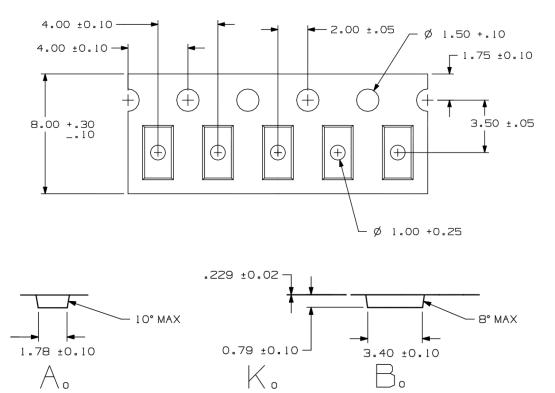
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to  $150^{\circ}$ C
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

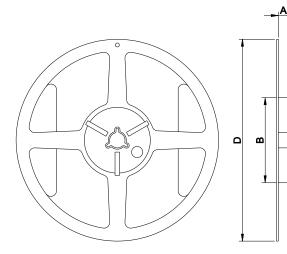


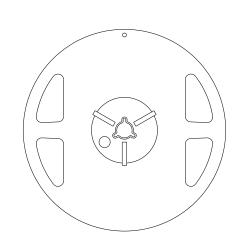
## 6.Packaging Information

#### **Tape Specification:**









7" x 8 mm

C

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~  $40^{\circ}$ C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.